

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/613,497	CHEN, TIENTEH	
Examiner	Art Unit	
Betelhem Shewareged	1774	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
AS TO DATE	11/1/2006	BS	
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